

# PARA LIGHT ELECTRONICS CO., LTD.

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# DATA SHEET

PART NO.: SZT2835IR1CT-150mA

REV : <u>A / 1</u>

CUSTOMER'S APPROVAL : \_\_\_\_\_ DCC : \_\_\_\_



## SZT2835IR1CT-150mA

REV:A/1

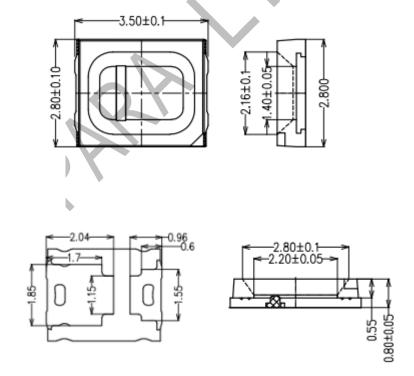
#### Features:

- 1. High radiant power and high radiantintensity.
- 2. Lens Appearance: Water clear.
- 3. 3.5\*2.8\*0.8mm standard package.
- 4. Suitable for all SMT assembly methods.
- 5. Compatible with infrared and vapor phasereflow solder process.
- 6. Compatible with automatic placement equipment.
- 7. This product doesn't contain restrictionSubstance, comply ROHS standard.

#### Applications:

- 1. Lighting
- 2. Automotive lighting.
- 3. Backlighting: LCDs
- 4. Status indicators: Consumer & industrial electronics.
- 5. General use.

## PackageDimensions:



#### NOTES:

- 1.All dimensions are in millimeters.
- 2. Tolerance is ±0.10mm unless otherwise specified.
- 3. Specifications are subject to change without notice



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## ■ Absolute Maximum Ratings(Ta=25°C)

Parameter	Symbol	Rating	Unit	
Power Dissipation	Pd	225	mW	
Forward Current	I <sub>F</sub>	150	mA	
*1Peak Forward Current	I <sub>FP</sub>	200	mA	
Operating Temperature	Topr	-30~+80	${}^{\circ}\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!$	
Storage Temperature	Tstg	-40~+100	${\mathbb C}$	
Soldering Temperature	Tsol	See Page 7	-	

Note: IFP is pulse of 1/10 duty at 1KHz

■ Electrical and optical characteristics(Ta=25°C)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Radiant Intensity	le	I <sub>F</sub> =150mA	- ^	30		mW/sr
Forward Voltage	$V_{F}$	I <sub>F</sub> =150mA	1.40		1.60	V
Reverse Current	I <sub>R</sub>	V <sub>R</sub> =5V		-	100	μA
Peak Wavelength	λр	I <sub>F</sub> =150mA	-	940	-	nm
Spectral Line Half- Width	Δλ	I <sub>F</sub> =150mA	-	50	-	nm
Viewing Angle	2θ <sub>1/2</sub>	I <sub>F</sub> =150mA	-	120	-	deg

# Intensity Bin Limits (At 150 mA)

BIN CODE	mW/sr	mW/sr
IR11	20	25
IR12	25	30
IR13	30	35

Tolerance for each Bin limit is ±10%.



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# ● Typical Electro-Optical Characteristics Curves.

Fig.1 - Relative Radiant Flux vs. Forward Current

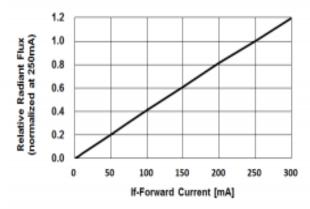


Fig.3 – Relative Radiant Flux (@ 250mA) vs. Ambient Temperature

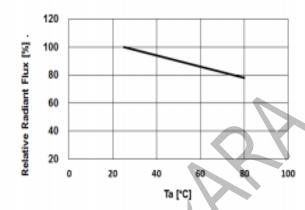


Fig.5 – Peak Wavelength (@250mA) vs. Ambient Temperature

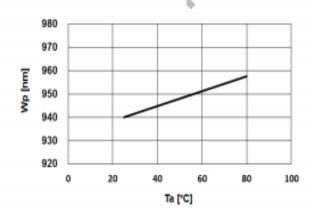


Fig.2 - Forward Current vs. Forward Voltage

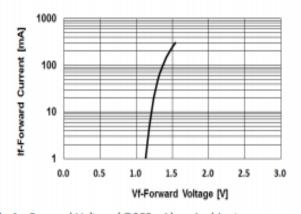


Fig.4 – Forward Voltage (@250mA) vs. Ambient Temperature

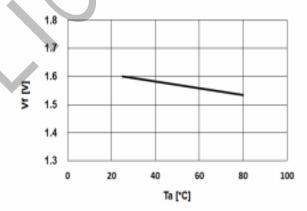
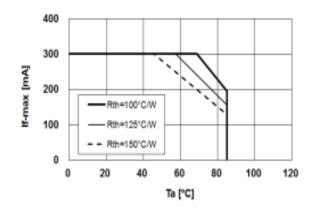


Fig.6 – Maximum Driving Forward DC Current vs. Ambient Temperature (De-rating based on Tj max. = 115°C)

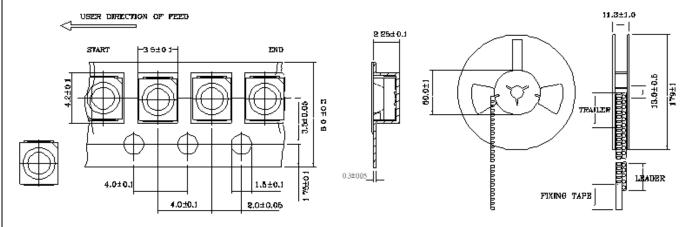




# SZT2835IR1CT-150mA

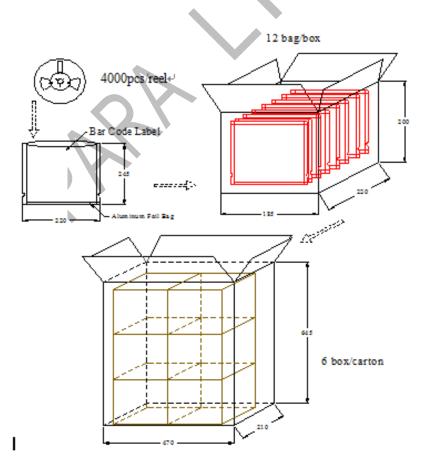
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# ● Tapping and packaging specifications(Units: mm)



NOTE:2000 PCS PER REEL

## Package Method:(unit:mm)





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Reliability Test

Classification	Test Item	Reference Standard	Test Conditions	Result
Endurance Test	Operation Life	MIL-STD-750:1026 MIL-STD-883:1005 JIS-C-7021 :B-1	I <sub>F</sub> =50mA Ta=Under room temperature Test time=1,000hrs	
		MIL-STD-202:103B JIS-C-7021 :B-11	Ta=+65°C±5°C RH=90%-95% Test time=240hrs	0/20
	High Temperature Storage	MIL-STD-883:1008 JIS-C-7021 :B-10	High Ta=+85°C±5°C Test time=1,000hrs	
	Low Temperature Storage	JIS-C-7021 :B-12	Low Ta=-35°C±5°C Test time=1,000hrs	0/20
	Temperature Cycling	MIL-STD-202:107D MIL-STD-750:1051 MIL-STD-883:1010 JIS-C-7021 :A-4	$-35$ $^{\circ}$	0/20
Environmental Test	Thermal Shock	MIL-STD-202:107D MIL-STD-750:1051 MIL-STD-883:1011	-35°C±5°C ~+85°C±5°C 20min 20min Test Time=10cycle	0/20
	Solder Resistance	MIL-STD-202:201A MIL-STD-750:2031 JIS-C-7021 :A-1	Preheating: 140°ℂ-160°ℂ,within 2 minutes. Operation heating: 260°ℂ(Max.), within 10seconds. (Max.)	0/20

## Judgment criteria of failure for the reliability

Measuring items	Symbol	Measuring conditions	Judgment criteria for failure
Forward voltage	$V_{F}(V)$	I <sub>F</sub> =150mA	Over U <sup>1</sup> x1.2
Reverse current	$I_R(uA)$	V <sub>R</sub> =5V	Over U <sup>1</sup> x2
Luminous intensity	lv ( mcd )	I <sub>F</sub> =150mA	Below S <sup>1</sup> X0.5

#### Note:

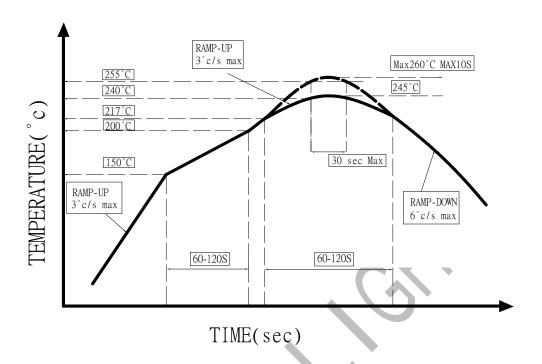
- 1. U means the upper limit of specified characteristics. S means initial value.
- 2. After each test, remove test pieces, wait for 2 hours and test pieces have returned to ambient temperature, then take next measurement.



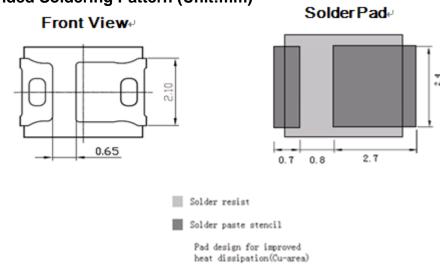
## SZT2835IR1CT-150mA

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IR-Reflow



- 1. Avoid any external stress applied to the resin while the LEDs are at high temperature, especially during soldering.
- 2. Avoid rapid cooling or any excess vibration during temperature ramp-down process
- Although the soldering condition is recommended above, soldering at the lowest possible temperature is feasible for the LEDs
- ●IRON Soldering 300°C Within 3 sec, one time only.
- Recommended Soldering Pattern (Unit:mm)





### SZT2835IR1CT-150mA

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#### Handling:

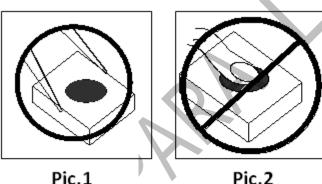
Care must be taken not to damage LED's epoxy resin while exposing to high temperature or contact LED's epoxy resin with hard or sharp objects, such as metal hook, tweezer or sand blasting.

Handling Precautions

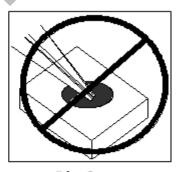
Compare to epoxy encapsulant that is hard and brittle, silicone is softer and flexible. Although its characteristic significantly reduces thermal stress, it is more susceptible to damage by external mechanical force.

As a result, special handling precautions need to be observed during assembly using silicone encapsulated LED products. Failure to comply might lead to damage and premature failure of the LED.

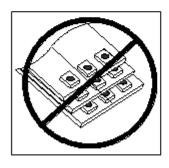
- 1. Handle the component along the side surfaces by using forceps or appropriate tools.(pic.1)
- 2. Do not directly touch or handle the silicone lens surface. It may damage the internal circuitry. (pic.2.pic.3)
- 3. Do not stack together assembled PCBs, containing exposed LEDs. Impact may scratch the silicone lens or damage the internal circuitry. (pic.4)
- 4. The outer diameter of the SMD pickup nozzle should not exceed the size of the LED to prevent air leaks. The inner diameter of the nozzle should be as large as possible. (pic.5)
- 5. A pliable material is suggested for the nozzle tip to avoid scratching or damaging the LED surface during pickup. (pic.5)
- 6. The dimensions of the component must be accurately programmed in the pick-and-place machine to insure precise pickup and avoid damage during production. (pic.5)



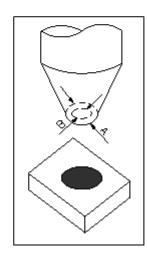
Pic.2



Pic.3



Pic.4₽





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#### Notes for designing:

Care must be taken to provide the current limiting resistor in the circuit so as to drive the LEDs within the rated figures. Also, caution should be taken not to overload LEDs with instantaneous voltage at the turning ON and OFF of the circuit.

When using the pulse drive care must be taken to keep the average current within the rated figures. Also, the circuit should be designed so as be subjected to reverse voltage when turning off the LEDs.

#### Storage:

In order to avoid the absorption of moisture, it is recommended to solder LEDs as soon as possible after unpacking the sealed envelope.

If the envelope is still packed, to store it in the environment as following:

- (1) Temperature: 5°C-30°C(41°F)Humidity: RH 60%Max.
- (2) After this bag is opened, devices that will be applied to infrared reflow, vapor-phase reflow, or equivalent soldering process must be:
- a. . Completed within 168 hours.
- b. . Stored at less than 30% RH.
- (3) Devices require baking before mounting, if: 2a or 2b is not met.
- (4) If baking is required, devices must be baked under below conditions: 48 hours at 60°C±3°C.

### Package and Label of Products:

Package: Products are packed in one bag of 4000 pcs (one taping reel) and a label is attached to each bag.